Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/769,920	HAYASHI ET AL.
Examiner	Art Unit

3616

Joselynn Y. Sliteris

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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
References cited: - US Pat. 6,113,131 - US Pat. 5,195,773 - US Pat. 5,997,030	5/2/2006	JYS			